EESR: Edge Enhanced Super-Resolution

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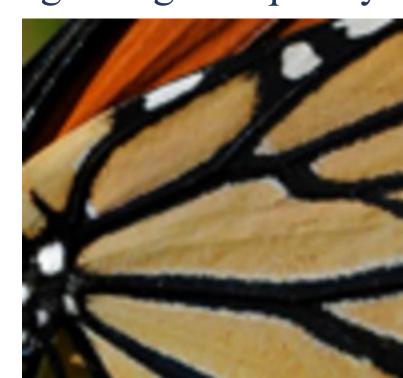
INTRODUCTION

➤ Motivation – To generate high-frequency structures in blind super resolution

- > Super Resolution (SR): Enhancing the resolution of and imaging system.
- > Traditional methods: Over-smoothly as a result of pursuing higher PSNR (peak signal to noise) and SSIM (structural similarity).
- > Recent networks using generative adversarial network (GAN) [1]: Having photorealistic result, but not easy to train.

Contribution

- An edge detection network is used to extract and preserve high-frequency structures.
- > GAN architecture is used for fine-tuning the generative network, instead of direct training.
- A new criterion "perceptive texture score" (PTS) is raised for better evaluating an image's high-frequency structures.





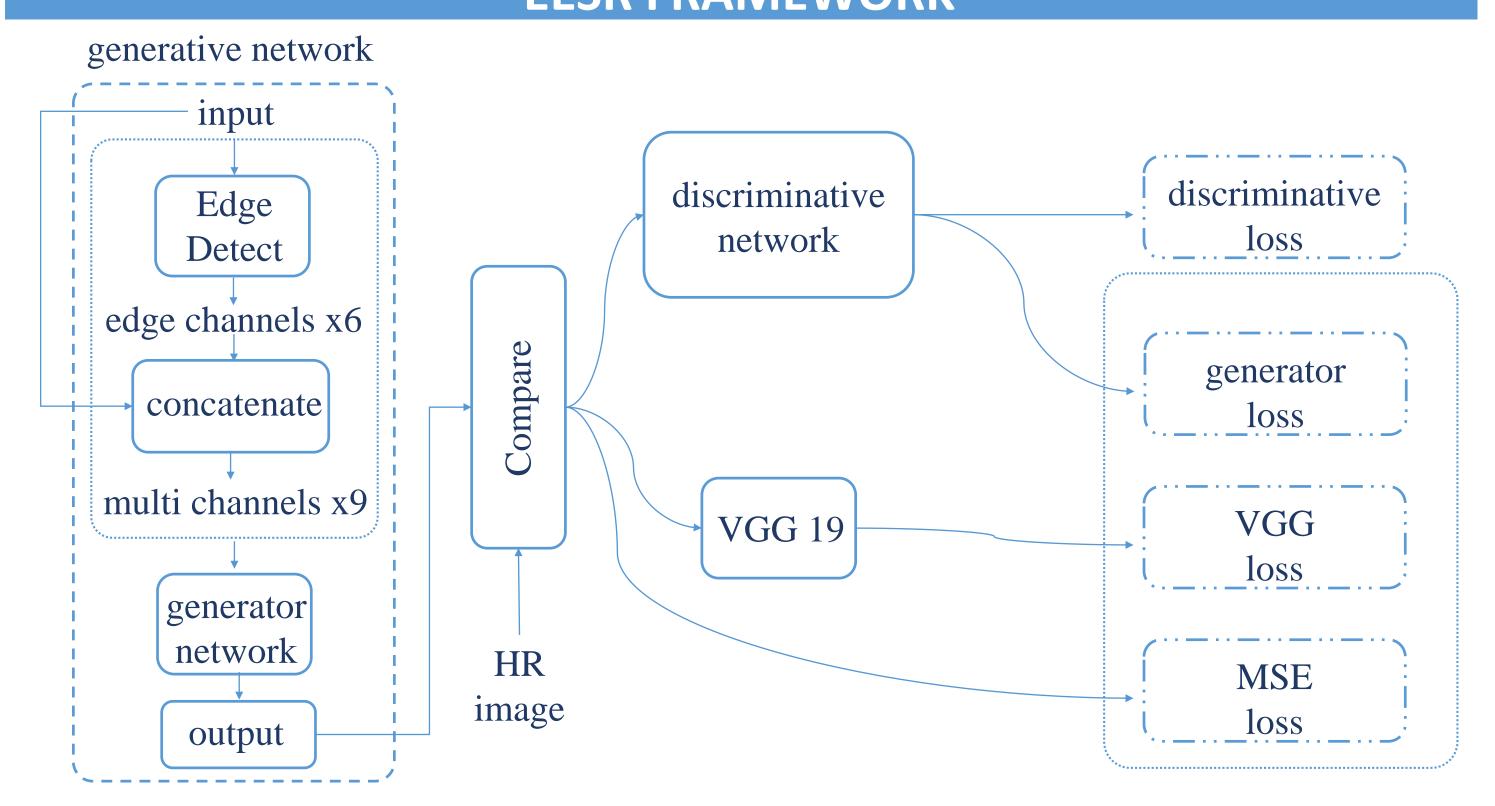


Low resolution input

Our result

Ground truth

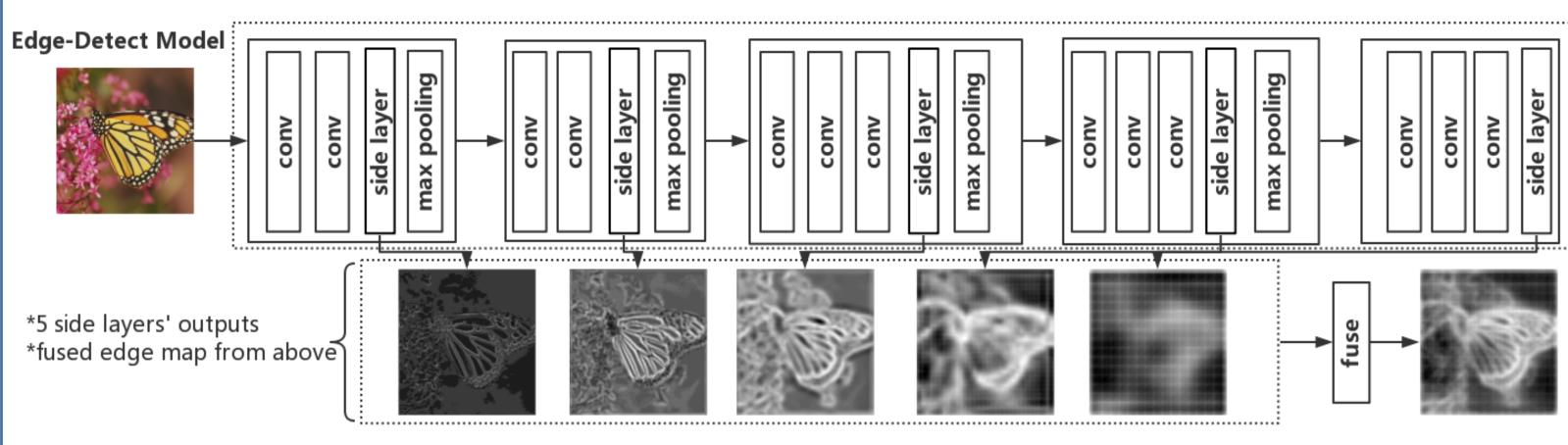
EESR FRAMEWORK



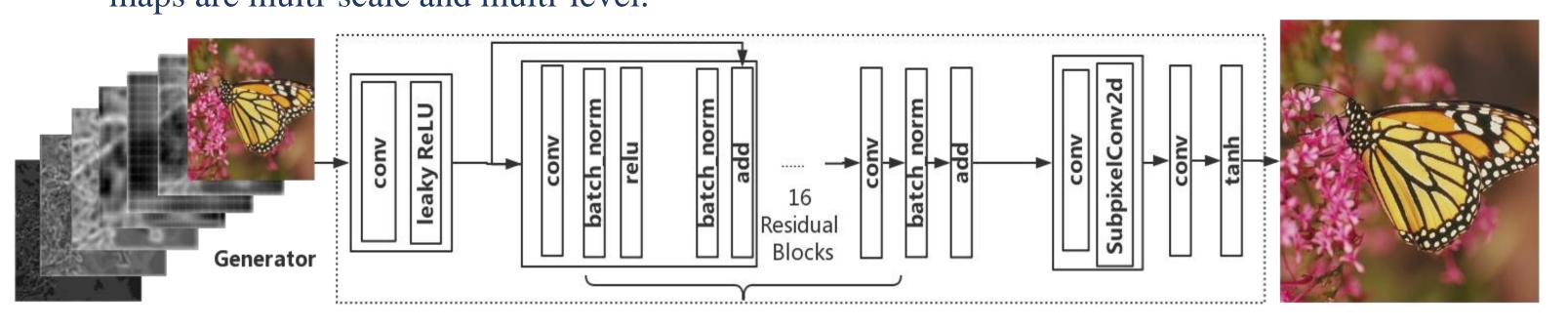
EESR has a generative network for training and a discriminative network for fine-tuning.

➤ Inference Steps

- Compute the edge channels using Edge Detect network.
- Concatenate edge channels with the input LR image to form a 9-channel input.
- Feed the generator network with the 9-channel input.
- Edge Detect Network
 - ➤ HED[2] model is used for edge detection.
- > 5 edge maps, together with 1 fused map, are concatenated with 3-channel RGB (from original LR image) to form a 9-channel input map of the generator network.

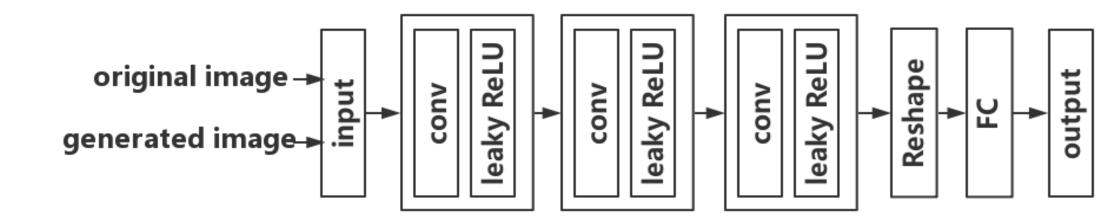


- Generator Network
- \triangleright Responsible for mapping LR image I^{LR} to SR image $G(I^{LR})$.
- ➤ Able to have a good preservation of high-frequency features of the original image, as the feature maps are multi-scale and multi-level.



Discriminator Network

- ➤ Discriminate SR samples from original HR images.
- ➤ Induce the generative network to generate indistinguishable SR images.
- > Only trained in fine-tuning iterations.



> Loss Function

- EESR network has two loss functions: generative and discriminative.
- Discriminative loss is optimized during fine-tuning:

$$L_{GAN-D} = \mathbb{E}_{\delta}(D(I^{HR}), \mathbb{I}) + \mathbb{E}_{\delta}(D(G(I^{LR})), \mathbb{O})$$

- ➤ Generative loss:
 - The loss from generator in GAN: $L_{GAN-G} = \mathbb{E}_{\delta}(D(G(I^{LR})), \mathbb{I})$
 - Mean Square Error (MSE): $L_{MSE} = \frac{1}{r^2 WHC} \sum_{x=1}^{rW} \sum_{y=1}^{rH} \sum_{z=1}^{C} (I_{x,y,z}^{HR} G(I^{LR})_{x,y,z})^2$
 - VGG[3] loss: $L_{VGG} = \frac{1}{MNK} \sum_{i=1}^{M} \sum_{j=1}^{N} \sum_{k=1}^{K} (V(I^{HR})_{i,j,k} V(G(I^{LR}))_{i,j}, k)^2$

The final loss function of generative network is a weighted mean of these three losses.

EVALUATION AND EXPERIMENTS

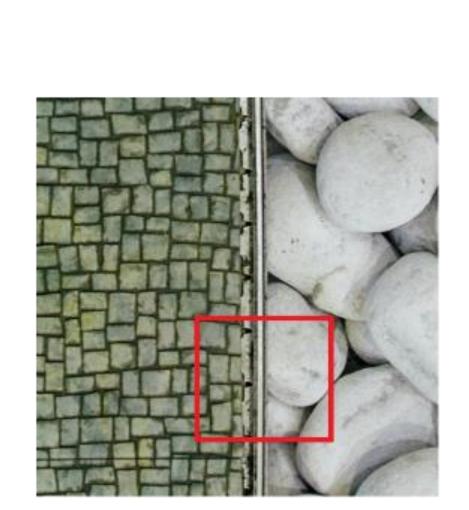
- > Evaluation perceptive texture score (PTS)
 - To quantify the quality of generated super resolved images.

Experiments

- Developing platform: Tensorflow 1.4.1, NVIDIA TITAN XP GPU
- Training and testing dataset: DIV2K
- Training details:
 - Initial learning rate 1e-4, decay rate of learning rate 1e-5;
 - > Training iterations 200 epochs, fine-tuning iterations 2000 epochs
 - > Batch size 16

Comparison with previous works on DIV2K

	Bicubic	VDSR[4]	SRGAN[5]	EDSR[6]	EESR
PSNR	22.2467	23.5969	23.4090	23.7904	22.3501
SSIM	0.7414	0.8102	0.8082	0.8288	0.7588
PTS	0.0767	0.1870	0.2383	0.2287	0.6210









SRGAN [5]

4 times super resolution result of our EESR compared with existing algorithms.

SUMMARY

- A new blind SR method, called EESR, is proposed.
- Edge pixels are focused by introducing an edge detection model.
- GAN is used to fine-tune our network
- EESR reaches an outstanding performance for 4 times up-sampling in preserving high-frequency structures and generating high quality SR images.

REFERENCE

- [1] Ian J. Goodfellow, Jean Pouget-Abadiey, Mehdi Mirza et al. Conference and Workshop on Neural Information Processing Systems (NIPS), pp 2672-2680 (2014).
- [2] Saining Xie, Zhuowen Tu. IEEE International Conference on Computer Vision (ICCV), pp 1395-1403 (2015).
- [3] K. Simonyan and A. Zisserman. International Conference on Learning Representations (2015).
- [4] Jiwon Kim, Jung Kwon Lee and Kyoung Mu Lee. Computer Vision and Pattern Recognition (CVPR), pp 1063-6919 (2016).
- [5] Christian Ledig, Lucas Theis, Ferenc Husz' ar et al. The IEEE Conference on Computer Vision and Pattern Recognition (CVPR), pp. 4681-4690 (2017).
- [6] Bee Lim, Sanghyun Son, Heewon Kim et al. CVPR workshop (2017).